

Device Modeling Report

COMPONENTS:

DIODE/ GENERAL PURPOSE RECTIFIER/ PROFESSIONAL

PART NUMBER: S5277G

MANUFACTURER: TOSHIBA

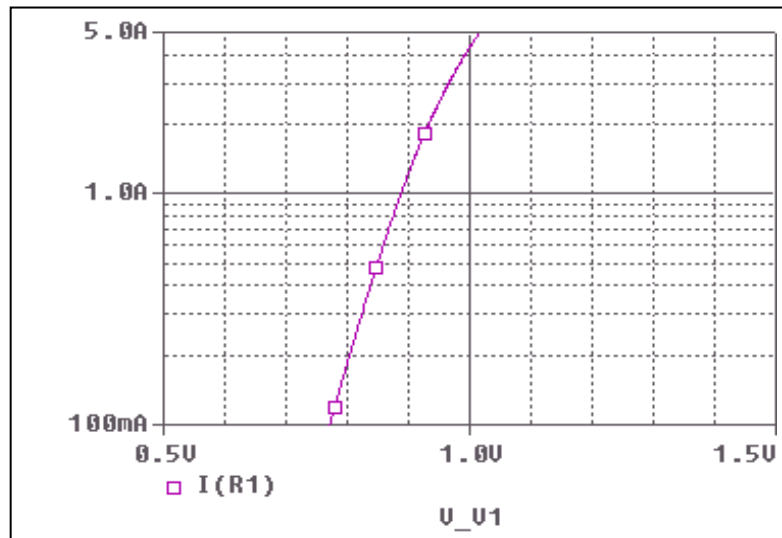


Bee Technologies Inc.

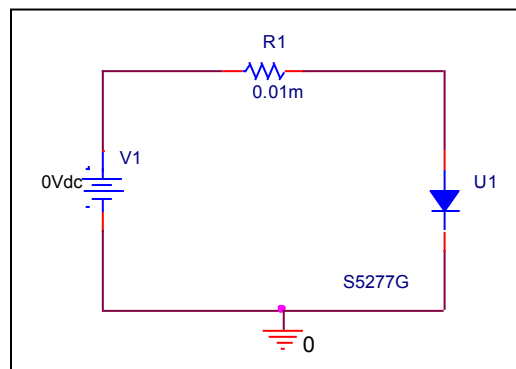
PSpice model parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time
EG	Energy-band Gap

Forward Current Characteristic

Circuit Simulation Result

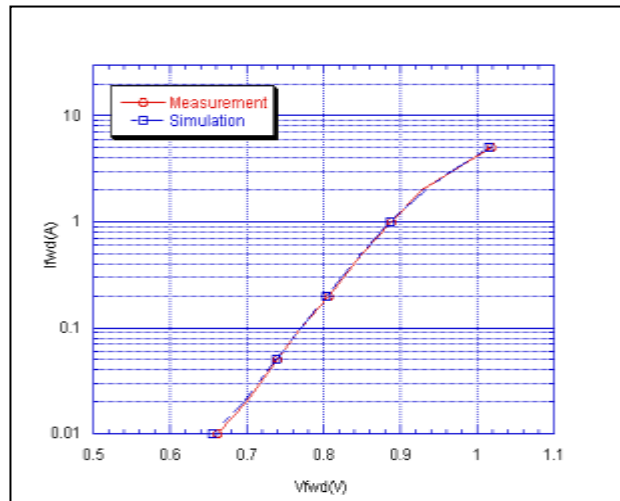


Evaluation Circuit



Comparison Graph

Circuit Simulation Result

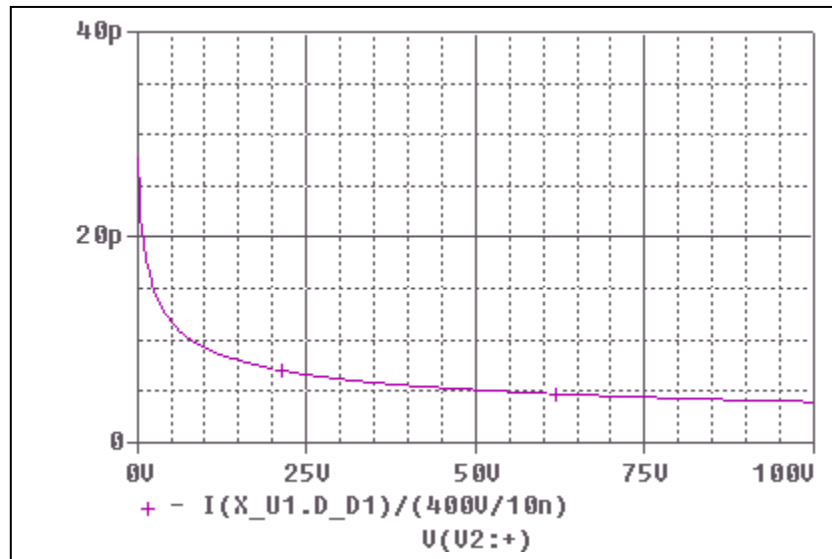


Simulation Result

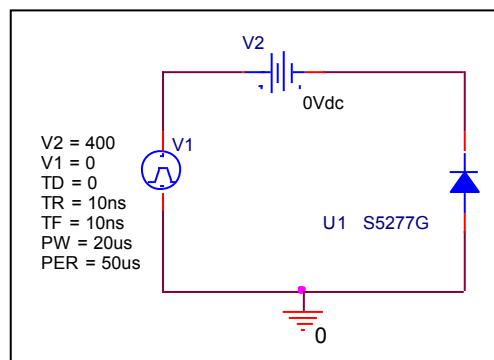
Ifwd(A)	Vfwd(V) Measurement	Vfwd(V) Simulation	%Error
0.01	0.662	0.656	0.982
0.02	0.700	0.697	0.371
0.05	0.740	0.739	0.149
0.1	0.770	0.771	-0.104
0.2	0.806	0.803	0.323
0.5	0.850	0.849	0.106
1	0.888	0.887	0.068
2	0.928	0.933	-0.517
5	1.018	1.016	0.226

Junction Capacitance Characteristic

Circuit Simulation Result

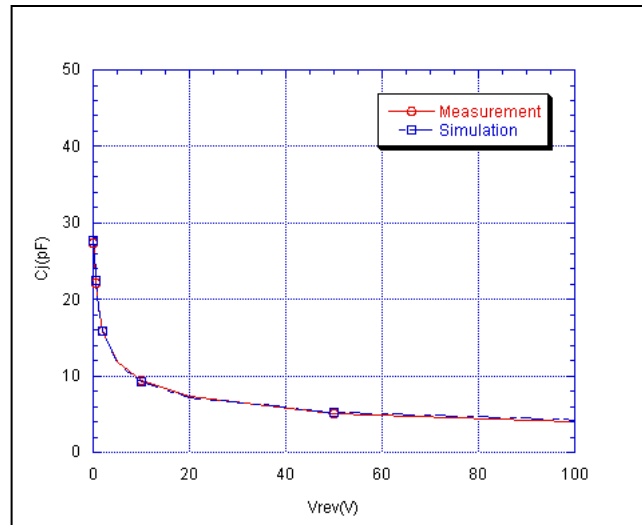


Evaluation Circuit



Comparison Graph

Circuit Simulation Result

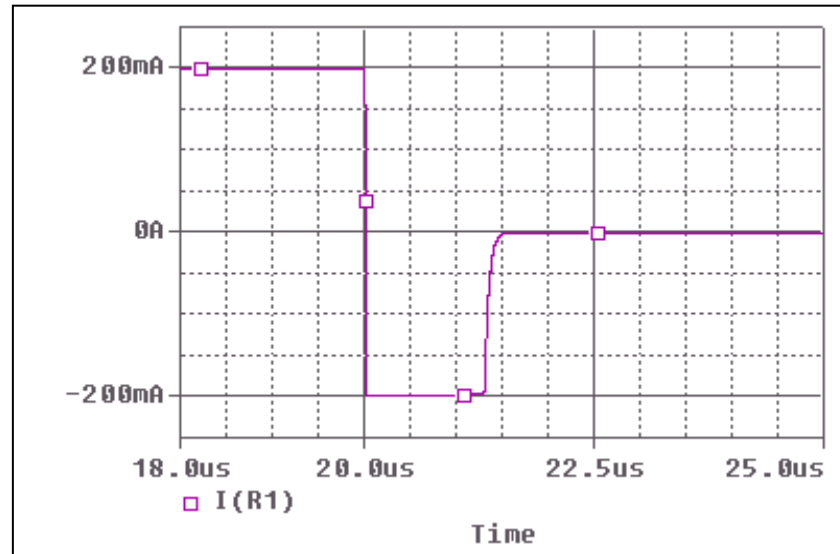


Simulation Result

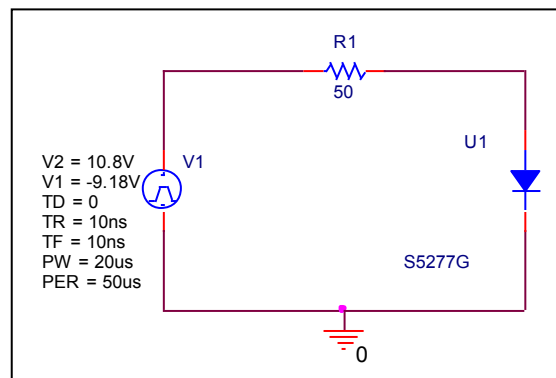
V_{rev} (V)	C_j (pF) Measurement	C_j (pF) Simulation	%Error
0	28.770	28.770	0.000
0.1	27.362	27.766	-1.477
0.2	25.737	25.992	-0.991
0.5	22.218	22.494	-1.242
1	18.955	19.247	-1.540
2	15.785	15.879	-0.596
5	11.877	11.764	0.951
10	9.362	9.250	1.193
20	7.277	7.200	1.047
50	5.107	5.148	-0.797
100	3.862	3.981	-3.065

Reverse Recovery Characteristic

Circuit Simulation Result



Evaluation Circuit

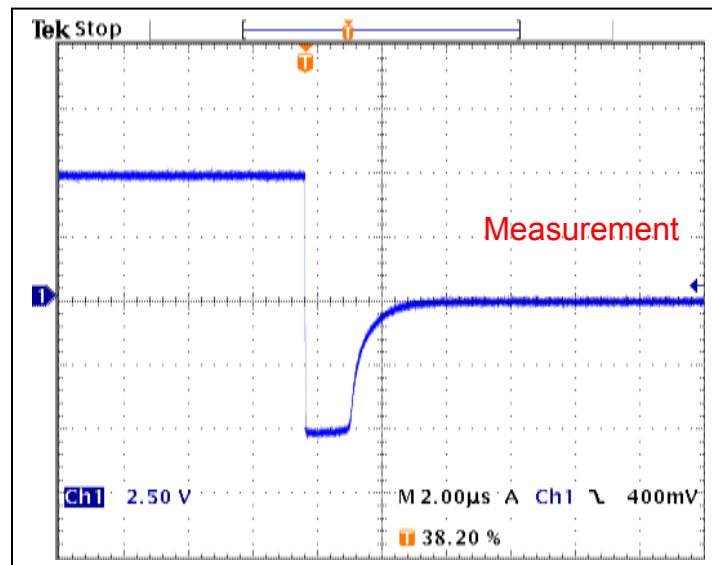


Compare Measurement vs. Simulation

	Measurement		Simulation		%Error
trj	1.28	μs	1.29	μs	0.781
trb	1.12	μs	1.11	μs	0.892

Reverse Recovery Characteristic

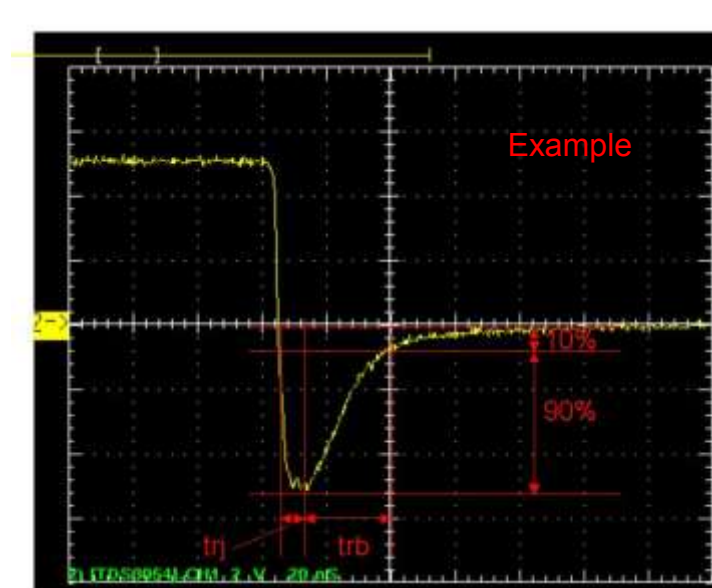
Reference



$Trj = 1.28(\mu s)$

$Trb = 1.12(\mu s)$

Conditions: $I_{fwd} = I_{rev} = 0.2(A)$, $R_L = 50$



Relation between trj and trb